


<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	09/605,361	JASON ET AL.	
	<b>Examiner</b>	<b>Art Unit</b>	
	Minh Dieu Nguyen	2137	

SEARCHED			
Class	Subclass	Date	Examiner
726	1,3-4	6/1/2006	MDN
713	150-151	6/1/2006	MDN
713	160, 162	6/1/2006	MDN
709	224,229	6/1/2006	MDN
709	227	6/1/2006	MDN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
726	1, 3-4	6/1/2006	MDN
713	151	6/1/2006	MDN
709	227	6/1/2006	MDN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated inventor name search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	6/1/2006	MDN
Updated text and class search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	6/1/2006	MDN
Consulted with M. Smithers on double patenting (7,028,332) and allowability issues	6/1/2006	MDN
Considered Patent 7,028,332	6/1/2006	MDN